

Sheet 1 of 2

INFORMATION DISCLOSURE
CITATION

ATTY. DOCKET NO.

4105-18

SERIAL NO.

10/615,600

APPLICANT

CHO et al.

FILING DATE

July 9, 2003

TC/A.U.

2627

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/JH/	2004/0263185	12/2004	Cho et al.	324	636	
	2004/0114913	06/2004	Kume	386	125	
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	2003/0021213	01/2003	Hagiwara, Yoshiaki	369	101	
	4,320,491	03/1982	Rustman, James C.	369	126	
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	5,481,527	01/1996	Kasanuki et al.	369	126	
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	5,914,920	06/1999	Yokogawa	369	275.3	
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	6,841,220	01/2005	Onoe et al.	428	66.7	
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DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/JH/ 2003085969	03/2003	JP			ABSTRACT
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/JH/ 10-334525	12/1998	JP			ABSTRACT
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*Examiner

/Joseph Haley/

Date Considered

05/09/2007

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Sheet 2 of 2

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/JH/	Kazuta et al, "Determination of crystal polarities of piezoelectric thin film using scanning nonlinear dielectric microscopy", Journal of European Ceramic Society 21 (2001) 1581-1584.
/JH/	The Institution of Electrical Engineers, Stevenage, GB; 1 June 2002; Hiranaga et al, "Nano-sized inverted domain formation in stoichiometric LiTaO ₃ /single crystal using Scanning Nonlinear Dielectric Microscopy", XP002292217.
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